Se	arch	Note	es

Application/Control No.	Applicant(s)/Patent unde Reexamination	Г
10/734,607	BAE ET AL.	-
Examiner	Art Unit	
Mariceli Santiago	2870	

SEARCHED			
Class	Subclass	Date	Examiner
313	500, 503, 505, 506	6/15/2006	My
257	40,59,72	6/15/2006	My
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	earched (see history)	6/15/2006	mz

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
international search report (References checked)	6/15/2006	usiz	
attached copy search history	6/15/2006	Msky	